

## LASER WAVELENGTH METER

**671** Series

## Reliable accuracy gives you greater confidence in your experimental results anywhere from the visible to mid-IR.

Wavelength information is critical for applications such as high-resolution laser spectroscopy, photochemistry, cooling/trapping, and optical sensing. The best way to accurately measure laser wavelength is with the 671 Series Laser Wavelength Meter. This system uses a proven Michelson interferometer-based design to measure the wavelengths of CW lasers to an accuracy as high as  $\pm$  0.2 parts per million. Continuous calibration with a built-in wavelength standard guarantees the reliable accuracy that is required for the most meaningful experimental results.





## **KEY FEATURES**

- Wavelength accuracy as high as  $\pm$  0.0001 nm.
- Continuous calibration with a built-in wavelength standard.
- Exceptional repeatability results in wavelength resolution as high as 0.03 pm.
- Operation available from 375 nm to 12 μm.
- Simultaneous measurement of optical power.
- Input power requirement as low as 10 μW.
- Straightforward operation with PC using USB or Ethernet interfaces.

- Convenient pre-aligned fiber-optic input for visible and near-IR wavelengths.
- Free-space aperture input with visible alignment aid for IR and mid-IR wavelengths.
- Display software provided to control measurement parameters and report wavelength data.
- Convenient tablet/smartphone application reports measurement data anywhere in the laboratory.
- Automatic data reporting using custom or LabVIEW programming eliminates the need for a dedicated PC.

SPECIFICATIONS			<b>671</b> Series
MODEL		671A	671B
ASER TYPE	CW and quasi-CW (repetition rate > 10 MHz)		
VAVELENGTH			
Range	VIS: NIR: IR:	375 - 1100 nm 520 - 1700 nm 1 - 5 µm	VIS: 375 - 1100 nm NIR: 520 - 1700 nm IR: 1 - 5 μm MIR: 1.5 - 12 μm
Accuracy 1, 2	±	± 0.2 ppm ± 0.002 nm @ 1000 nm : 0.002 cm <sup>-1</sup> @ 10,000 cm <sup>-1</sup> ± 60 MHz @ 300,000 GHz	± 0.75 ppm (± 1 ppm for MIR)  ± 0.0008 nm @ 1000 nm  ± 0.008 cm <sup>-1</sup> @ 10,000 cm <sup>-1</sup> ± 225 MHz @ 300,000 GHz
Repeatability <sup>3, 4, 5</sup>		0.03 ppm (± 0.03 pm @ 1 μm) 0.06 ppm (± 0.2 pm @ 3 μm)	± 0.1 ppm (± 0.1 pm @ 1000 nm)
Calibration	Continuous - built-in stabilized single-frequency HeNe laser		Continuous - built-in standard HeNe laser
Display Resolution	9 digits		8 digits
Units 6	nm, μm, cm <sup>-1</sup> , GHz, THz		
OWER (VIS/NIR) 7			
Calibration Accuracy	± 15%		
Resolution	2%		
Units	mW, μW, dBm		
PTICAL INPUT SIGNAL			
Maximum Bandwidth 8	1 GHz		10 GHz
Minimum Input <sup>9, 10</sup>	VIS: NIR: IR:	20 - 250 μW 10 - 580 μW 65 - 750 μW	VIS: 10 - 110 μW NIR: 10 - 250 μW IR: 65 - 750 μW MIR: 120 - 925 μW
IEASUREMENT RATE	4 H:	z (VIS / NIR) 2.5 Hz (IR)	10 Hz (VIS / NIR) 2.5 Hz (IR / MIR)
NPUTS/OUTPUTS			
Optical Input 11	VIS / NIR: Pre-aligned FC/UPC or FC/APC connector (9 µm core diameter) - optional free beam-to-fiber couplers Collimated beam, 2-3 mm diameter aperture, visible tracer beam to facilitate alignment		
Instrument Interface	USB and Ethernet interface with Bristol's Windows-based display program, and browser-based display application Library of commands (SCPI) for custom and LabVIEW programming using any PC operating system		
OMPUTER REQUIREMENTS 12		PC running Windows 7, 8, or 10, 1 GB available R	AM, USB 2.0 (or later) port, monitor, pointing device
NVIRONMENTAL <sup>10</sup>			
Warm-Up Time		< 15 minutes	None
Temperature	+15°C to +30°C (-10°C to +70°C storage)		
Pressure	500 - 900 mm Hg		
Humidity	≤ 90% R.H. at +40°C (no condensation)		
IMENSIONS AND WEIGHT			
Dimensions (H x W x L) 13	<b>VIS / NIR:</b> 5.6	5" x 6.5" x 15.0" (142 mm x 165 mm x 381 mm)	<b>IR / MIR:</b> 7.5" x 6.5" x 15.0" (191 mm x 165 mm x 381 mm)
Weight	14 lbs (6.3 kg)		
OWER REQUIREMENTS	90 - 264 VAC, 47 - 63 Hz, 50 VA max		
VARRANTY		5	years

- Defined as measurement uncertainty, or maximum wavelength error, with a confidence level of ≥ 99.7%.
- (2) Traceable to accepted physical standards.
- (3) For 671A, standard deviation for a 10 minute measurement period after the instrument has reached thermal equalibrium.
- (4) For 671B, standard deviation for a 1 minute measurement period after the instrument has reached thermal equalibrium. Long-term measurement variations due to longitudinal mode drift of the HeNe reference laser are  $< \pm 0.4$  ppm.
- (5) Wavelength resolution is approximately two times repeatability.
- Data in units of nm,  $\mu m$ , and cm<sup>-1</sup> are given as vacuum values.
- (7) The IR and MIR versions do not measure absolute power. An intensity meter displays relative power.
- Bandwidth is FWHM. When bandwidth is greater, wavelength accuracy is reduced.
- Sensitivity at specific wavelengths can be determined from graphs that are provided in the 671 Series Product Details brochure.
- Characteristic performance, but non-warranted.
- (11) IR and MIR required beam height is 5.4  $\pm$  0.25".
- (12) (13) For use with Bristol's Windows-based display porgram. Interface via SCPI can be done using any PC operating system.
- IR and MIR instrument height is adjustable (7.25  $\pm$  0.25") for alignment purposes.



